

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/511,522	CHANG ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Rita J. Desai	1625	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Abstract DN 121:222102 Jennifer Court et al 1994 Vol 2 pages 216-33
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